

PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU		EXAMINER			
10022349	12/20/2001	257	20	2811	\mathcal{D} .	. Wi-is			
**APPLICANTS: Hwang Hann-Ping; Lu Shing-Chii; **CONTiNuiNG DATA VERIFIED: ** FOREIGN APPLICATIONS VERIFIED:									
				[]			-		
Foreig.i priority cla	NOT PUBLISH	⊐ve	RESCI	ND L	ATTOR	NEY DOCKET NO			
35 USC 119 conditions met ☐ yes ☐ no					HWAN3013/EM				
Verified and Acknowledged Examiners's initials TITLE: Single-chip structure of silicon germanium photodetector and high-speed transistor									
					U.S.DEPT	, OF COMMJPAT.3 TM-PTO-4	36L(Rev 12-54:		

NOTICE OF ALLOWANCE MAILED			CLAIMS ALLOWED			
		· ·	Total Claims		Print Claim for O.G	
		Assistant Examiner				
ISSUE FEE			DRAWING			
Amount Due	Date Paid	1	Sheets Drwg.	Figs.Drw	g. Print Fig.	
		Primary Examiner		!		
TERMINAL DISCLAMER		PREPARED FOR ISSUE	Applicati n Examiner			
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		Office is resulted to admit Dec stay				

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